#### AAPM Summer School 2004

# The Nature of the Digital Image

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#### Outline

- What is digital imaging
- Basic descriptors of digital imaging

Field of view

Artifacts

Resolution

Efficiency

Speed

Uniformity

Latitude

Noise

Scatter sensitivity

Lag

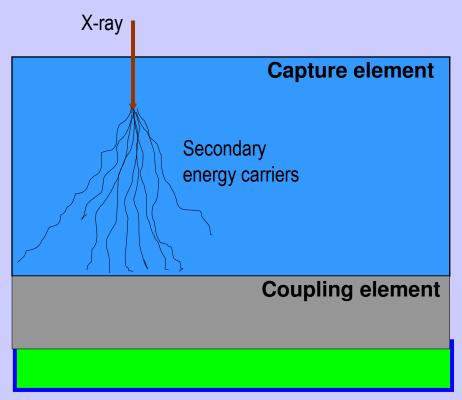
## Why digital imaging?

- Separation of the capture, processing, display, and storage functions
  - Improved dynamic range
  - Possibility of image post-processing
  - Improved image storage via PACS
  - Improved image transmission and distribution via PACS
  - New imaging applications (tomosynthesis, dual-energy)

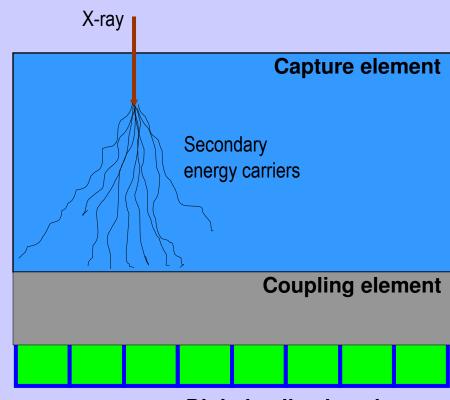
# What is digital imaging?

- Imaging in which the image data are sampled into discrete elements in spatial and intensity dimension
  - Initial image capture in analog mode
  - Digitization of analog to digital data
  - Processing and transfer of the digital data by computers

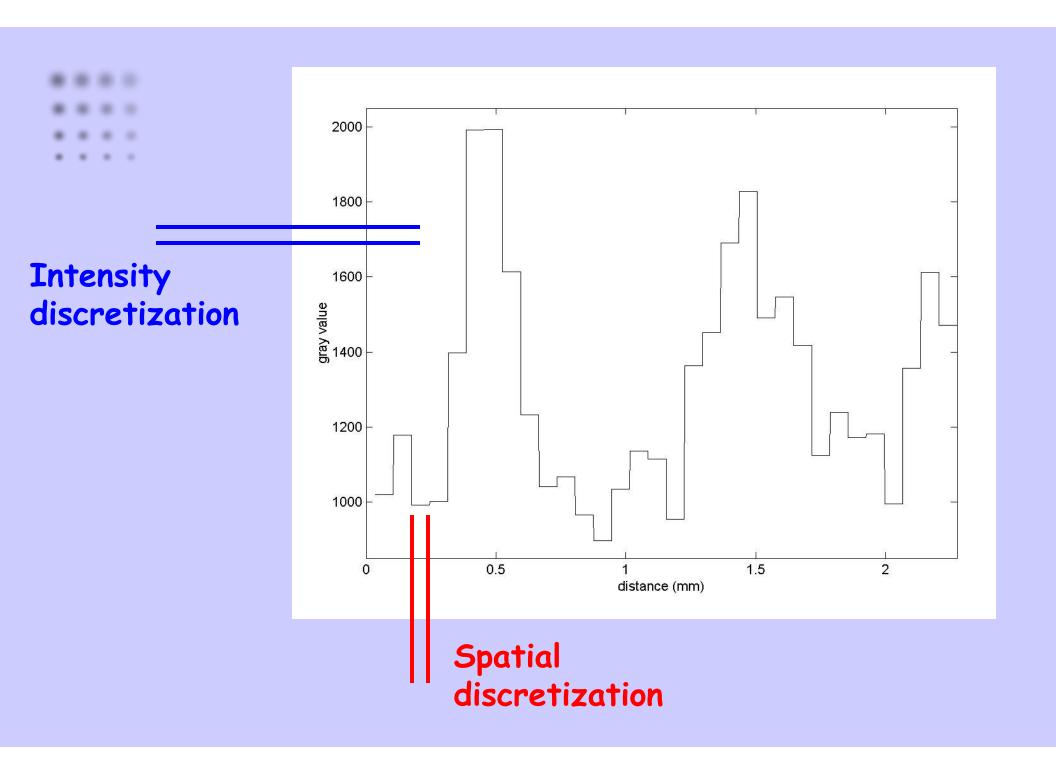
# Analog => Digital







**Digital collection element** 



#### Digital technologies

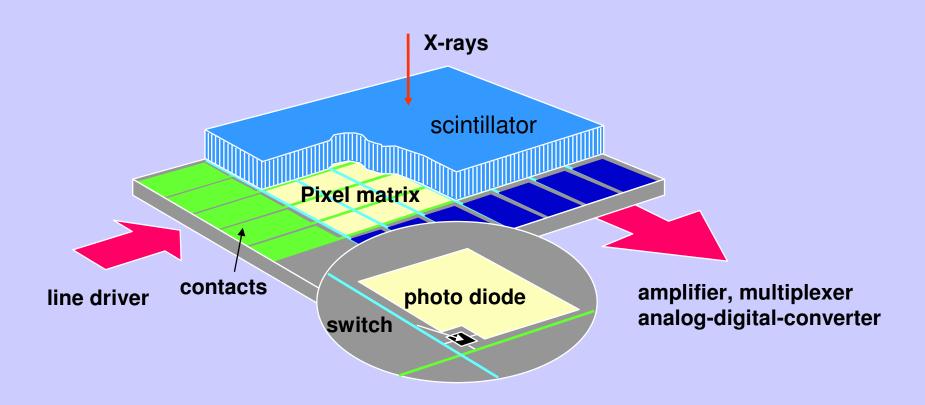
- 1. Computer Radiography (CR)
- 2. Flat-panel radiographic and fluoro systems

  Direct detectors

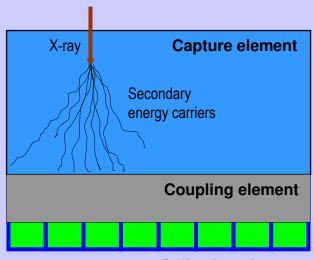
  Indirect detectors
- CCD/CMOS-based radiographic and fluoro systems
   Full-field detectors
   Scanning-slot detectors
- 4. Electrostatic radiographic system

  Selenium drum detector

#### Digital technologies



# Digital technologies



**Collection element** 

Detector	Typical capture	Typical coupling	Collection element
Technology	element	element	
CR	PSL phosphor	PSL light-guide	Photo-multiplier tube;
	(e.g., BaFBr)		signal digitization
CCD/CMOS-based	CsI or G <sub>2</sub> O <sub>2</sub> S phosphor	Lens or fiber-optic taper	CCD or CMOS
Indirect flat panel	Csl or G <sub>2</sub> O <sub>2</sub> S phosphor	Contact layer	Photodiode /TFT array
Direct flat panel	a-Se	None	TFT array
Electrostatic	a-Se	Induction space	Electrometer probes;
			signal digitization

# Basic descriptors of the digital image

- 1. Field of view
- 2. Uniformity
- 3. Spatial artifacts
- 4. Latitude
- 5. Spatial resolution

- 6. Noise
- 7. Efficiency
- 8. Scatter sensitivity
- 9. Speed
- 10.Lag

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#### Field of view

 Detector size should match the anatomy being imaged

 $-20 \times 25 \text{ cm}$ 

 $-18 \times 23$  and  $25 \times 29$  cm

 $-43 \times 43$  cm

 $-30 \times 30 \text{ cm} +$ 

extremity

mammography

chest and general rad

fluoro

 Particular challenge for most DR technologies

# Sub-detector tiling

 Potential for large-area nonuniformities and discontinuities



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#### Uniformity

- Applies to uniformity of response within the field of view of the imaging system
- Affected by non-linear response of pixel elements
- Can be minimized if capture and collection elements are coupled
  - Offset and gain calibration

#### Uniformity

· Offset and gain calibration

$$P_{c}(i,j) = (P_{uc}(i,j) - O_{m}(i,j)) \frac{M}{G_{n}^{XV}(i,j) - O_{m}(i,j)}$$

 $P_c(i,j)$  = corrected pixel value at coordinate (i,j)

 $P_{uc}(i,j)$  = uncorrected pixel value at (i,j)

 $G_n^{XV}(i,j)$  = gain image, average of n sequential flat-field images at X exposure and V kVp

 $O_m(i,j)$  = offset image, average of m sequential flat-field images with no exposure

$$M = \langle G_n^{\times V} - O_m \rangle$$

# Before calibration After calibration

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#### Spatial artifacts

- Pixel dropouts
  - Corrected by dead pixel corrections but can lead to image data loss
- Sub-detector seams
  - Partially corrected by gain calibration
- · Grid lines
  - Partially corrected by gain calibration
- · CR artifacts
  - Dust and scanning optics non-uniformity

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#### Latitude

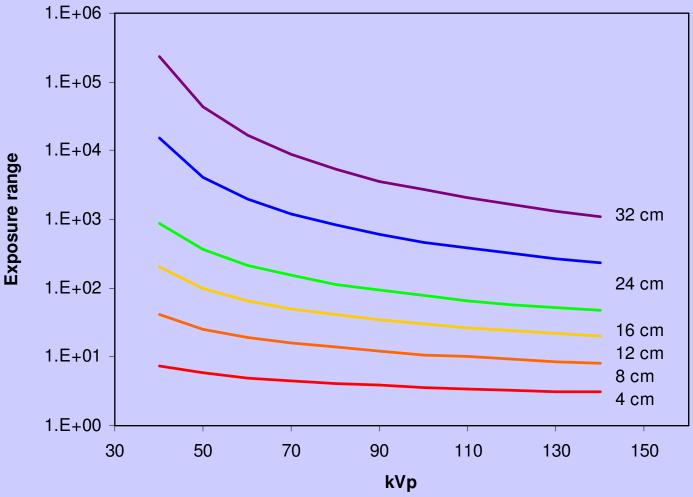
- a) The dynamic range over which the detector is able to provide clinically useful images
- b) The detector response within its dynamic range
- c) Signal quanitization within the dynamic range

## a) Dynamic range

$$DR = \frac{E_{Max}}{k E_{Min}}$$

- E<sub>max</sub>: Saturation exposure
  - e.g. exposure for PV=4095 in a 12-bit detector
- E<sub>min</sub>: Base exposure
  - Exposure raising PV just above dark noise
- K: threshold SNR
  - 3-5 based on Rose model

#### a) Dynamic range Radiography & fluoroscopy



xSpect, muscle-equivalent material, 2 mm intrinsic Al

#### a) Dynamic range Mammography

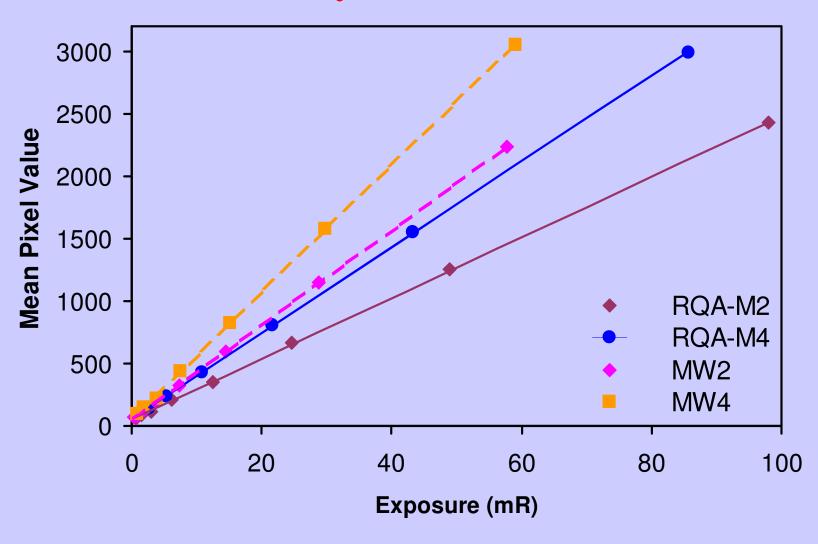
1.E+06 1.E+05 1.E+04 Exposure range 8 cm 6 cm 1.E+03 4 cm 1.E+02 2 cm 1.E+01 1.E+00 22 24 26 28 30 32 34 36 kVp

xSpect, 50/50% glandular/adipose, 30 um intrinsic Mo

#### b) Response

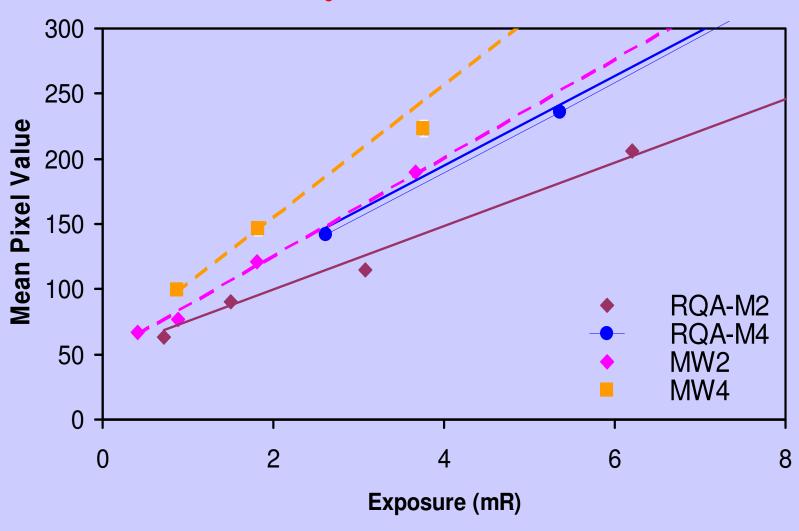
- Within the dynamic range, the detector response should be well-behaved
  - Linear
  - Logarithmic
  - Square-root
- Particular problems at low and high exposures limiting effective latitude

#### b) Response



Siemens prototype FFDM unit

#### b) Response



Siemens prototype FFDM unit

#### c) Quantization

- Within the dynamic range, the detector should provide sufficiently fine contrast discritization
- With logarithmic response  $C_{PV} = 1/g$
- With linear response  $C_{PV} = 1/PV$ 
  - e.g., 200:1 dynamic range, g=1
  - 12 bit log response  $C_{PV} = 200/4095 = 0.5\%$
  - 10 bit log response  $C_{PV} = 200/1023 = 2\%$
  - 12 bit linear response  $C_{PV} = 100\% 0.025\%$

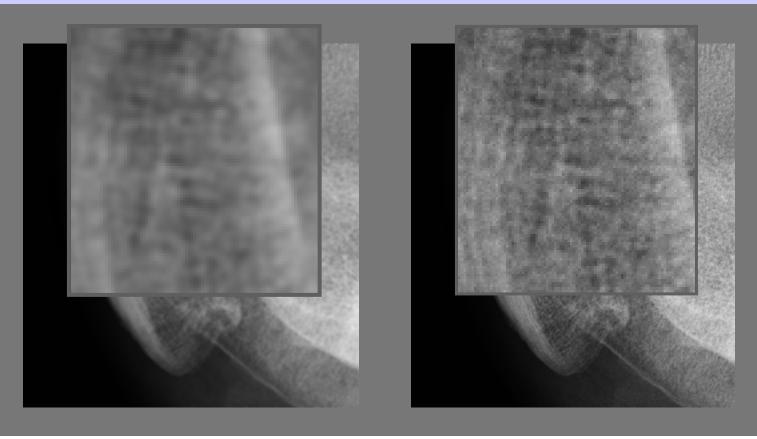
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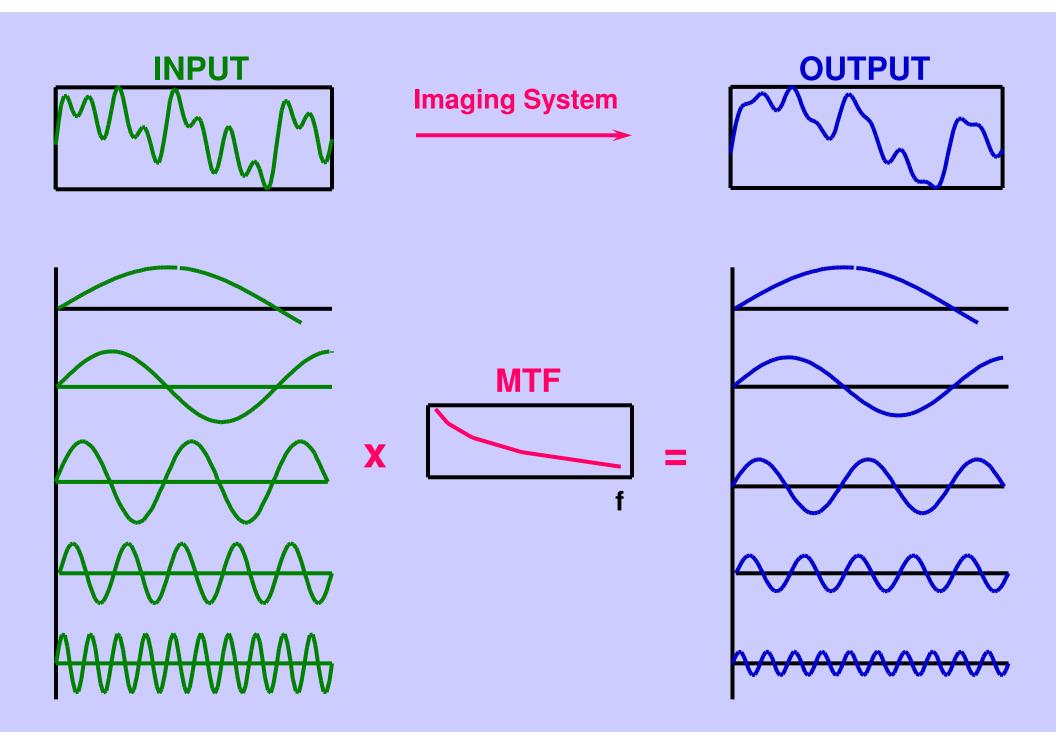
#### Resolution

 Ability to image/resolve distinct features of the imaged object from each other

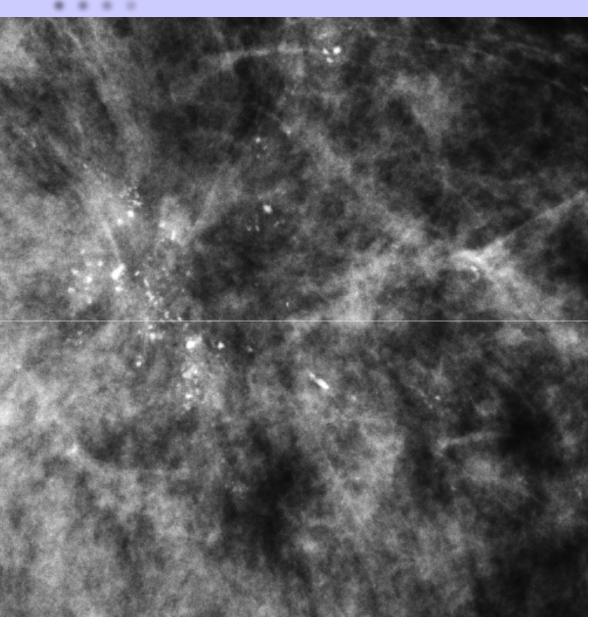


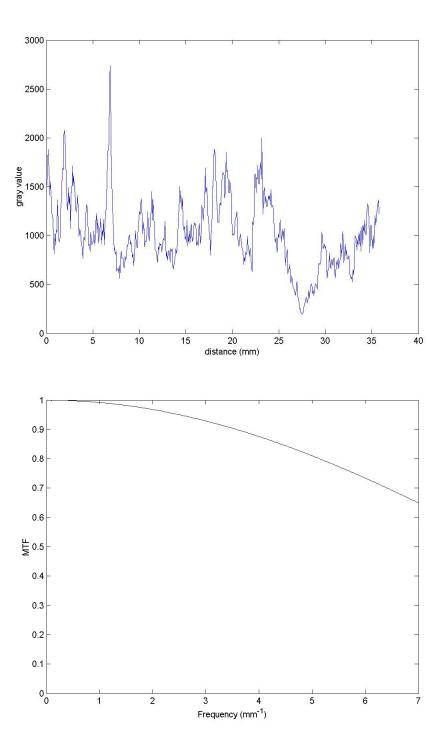
#### Resolution

- Best characterized by the modulation transfer function (MTF):
  - The efficiency of the imaging system in producing contrast at various spatial frequencies
- · Higher the MTF, better the resolution

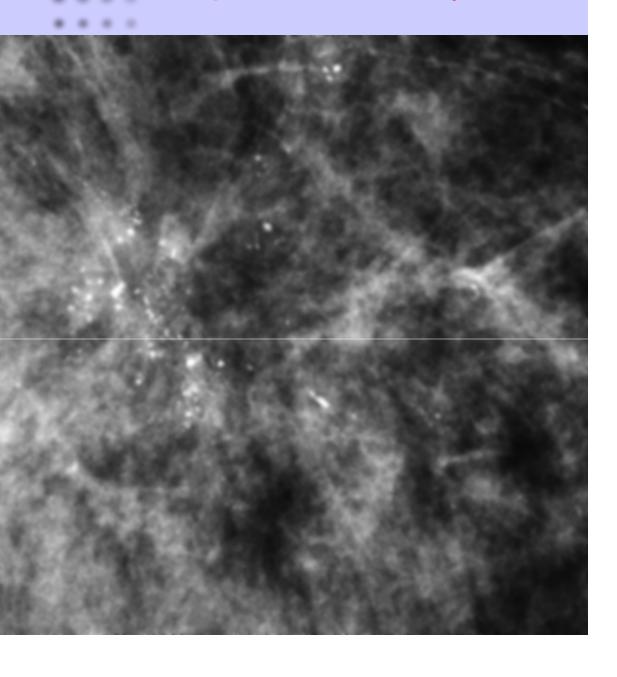


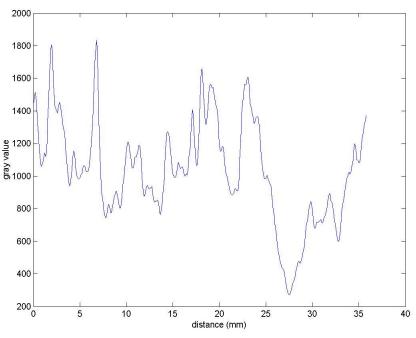
# High MTF

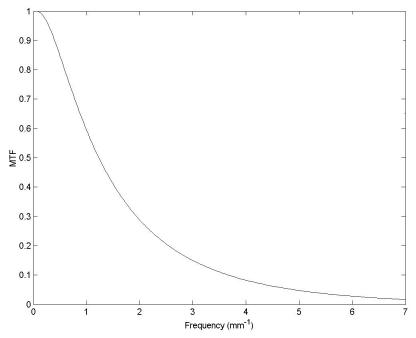




#### Low MTF





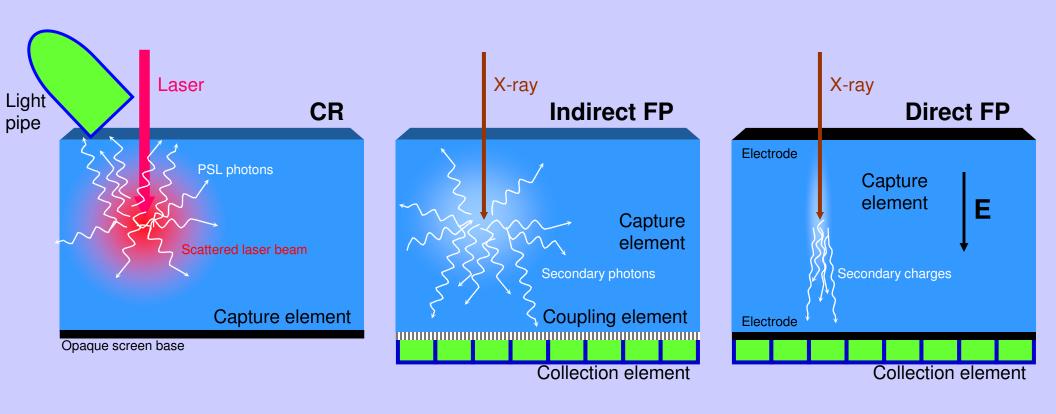


#### Resolution factors

- 1. Capture element blur
- 2. Coupling element blur
- 3. Collection element blur
- 4. Geometrical blur (focal spot penumbra)
- 5. Motion blur

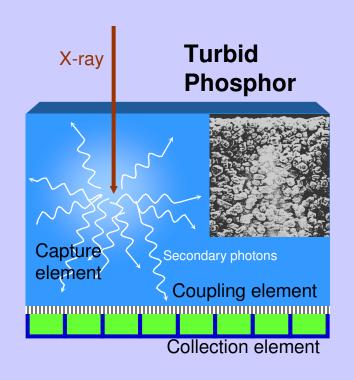
#### Capture element blur

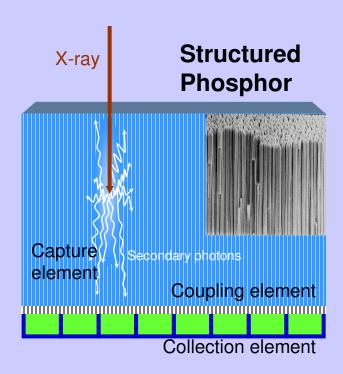
- Due to spreading of secondary energy-carriers
- Dominant in CR and indirect FPs



### Capture element blur

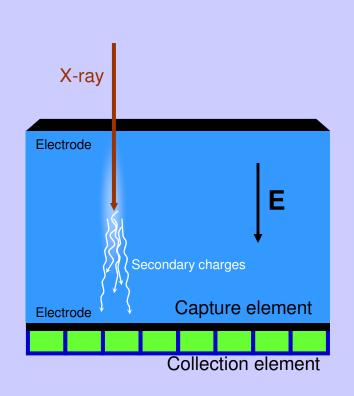
Can be reduced using structured phosphors

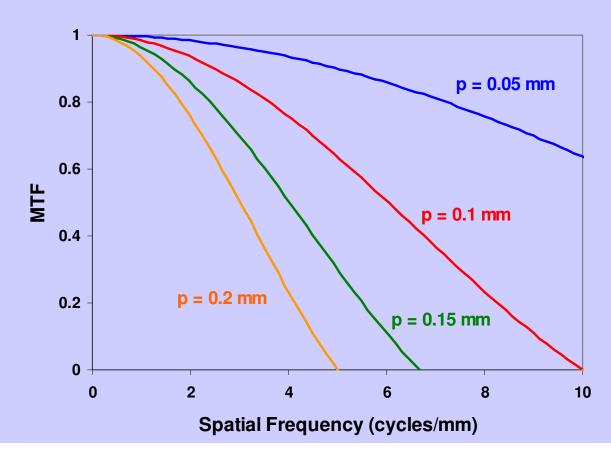




#### Collection element blur

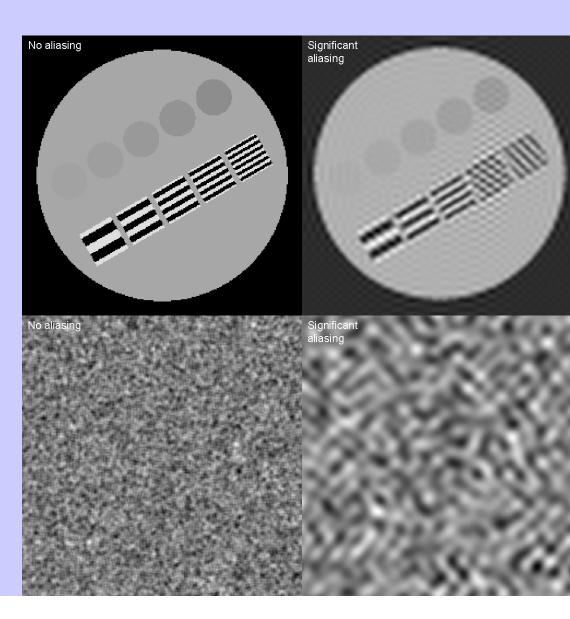
- Inherent resolution limit in CR and DR due to finite aperture size ~ 1/2p
- Dominant in direct FPs and electro-static DRs





#### Collection element blur

- Very high MTF =>
- Aliasing
  - Distortion of the low-frequency components of the image due to undersampled high-f details



### Techniques

- Three common methods:
  - Square Wave Response Method
  - Slit method
  - Edge method
- · Newer methods:
  - Disk method (3D)
  - Multiple-hole method (3D)

### Techniques

- Comparable to desirable application, 50-120 kVp, or 25-35 kVp for mammo
- · Filtration necessary to
  - Make spectrum similar to post-patient's
  - Remove lower energy x-rays responsible for most tube-to-tube variations

#### Assessment methods

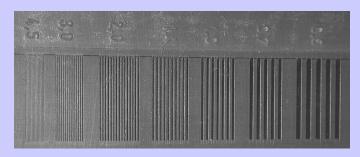
#### · RQA techniques per IEC 61267

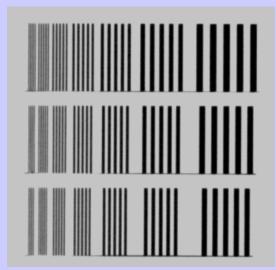
Technique	kVp	Filtration (mm Al)	HVL (mm Al)	SNR²/mm²mR (counting)
RQA5	70	21.0	7.1	255,232
RQA9	120	40.0	11.5	273,548
RQA-M2	28	2.0	0.56	47,231
RQA-M4	35	2.0	0.68	55,587

### MTF methodology

Square Wave Response Method

- Bar pattern test device
- SWR deduced from image data
- MTF estimated from SWR
- Advantages:
  - Simple and quick
- Disadvantages:
  - Low precision
  - Susceptible to noise
  - Coarse sampling of the MTF





## MTF methodology Slit Method

- Slit test device
- LSF deduced from image data
- · MTF from LSF via Fourier transformation
- Advantages:
  - High precision, particularly at high frequencies
  - Established method
- · Disadvantages:
  - Precise alignment necessary
  - Multiple acquisitions
  - Extrapolation of LSF tails and low low-f precision





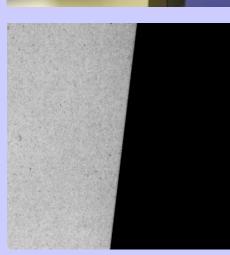
### MTF methodology

Edge Method

Edge test device

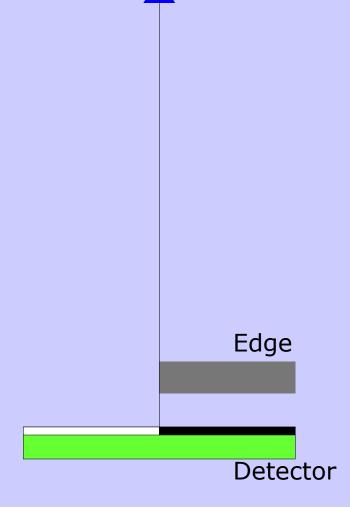
- ESF deduced from image data
- MTF from ESF via differentiation and Fourier transformation
- Advantages:
  - High precision, particularly at low frequencies
  - Simple and quick alignment
  - Established method (endorsed by the IEC)
- Disadvantages:
  - Susceptible to noise due to differentiation
  - Less precise at high frequencies





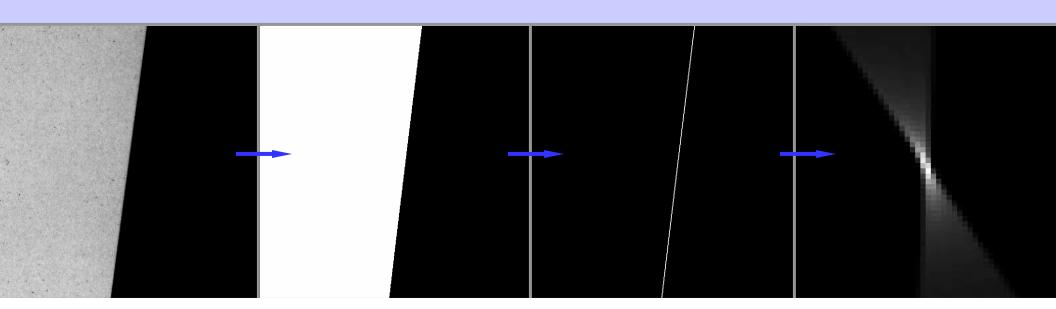
# MTF methodology Edge Method

- · Edge image acquisition
  - Largest possible SID
  - Smallest possible focal spot
  - Desired technique
  - @ 2/3 of max exposure



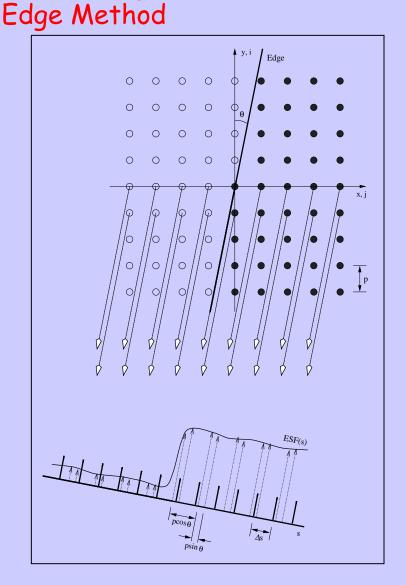
# MTF methodology Edge Method

- Edge image processing
  - Linearize the image data wrt exposure (per linear system theory requirement)
  - Finding the edge angle (Least square fits or differentiation and Hough transformation)



### MTF methodology

- · Edge image processing
  - 2D projection of the image data to obtain the ESF
  - Differentiation and smoothing of the ESF to obtain the line spread function (LSF)
  - Fourier transformation of the LSF to get the presampled MTF
  - Normalization of the MTF at 0 spatial frequency



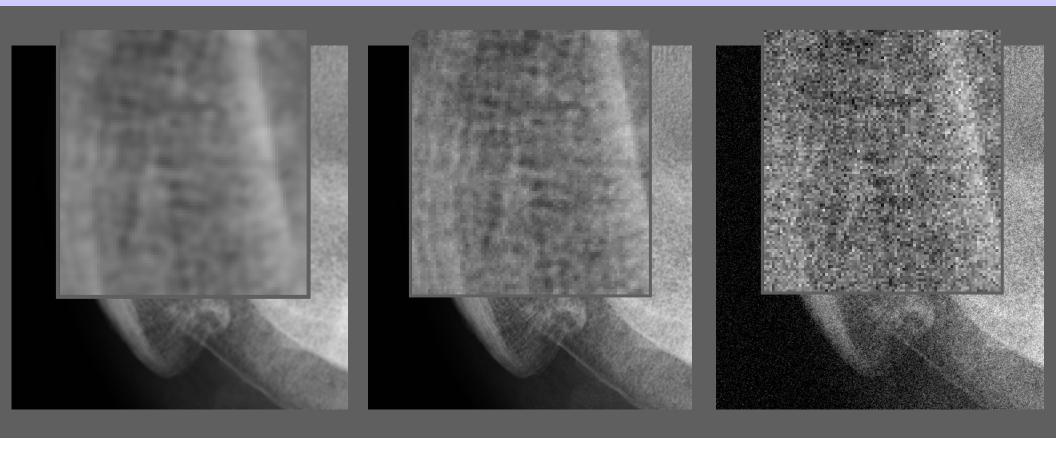
### Basic descriptors of the digital image

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#### Noise

Unwanted signals that interfere with interpretation



#### Noise

- Best characterized by the noise power spectrum (NPS):
  - The variance of noise in an image in terms of spatial frequency components
- · Lower the NPS, better the noise

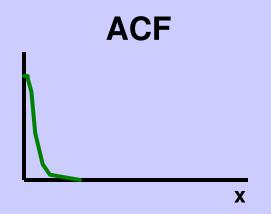
$$NPS(f) = \Im\{ACF(x)\}$$

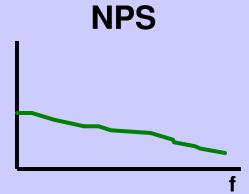
$$ACF(x) = \frac{1}{L} \int_{L} \Delta i(x + x') \Delta i(x') dx'$$

#### **NPS**

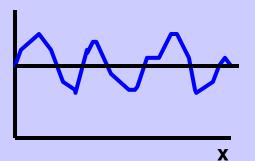
Example 1
Uncorrelated
Noise

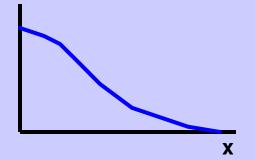


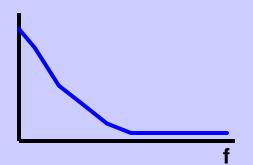




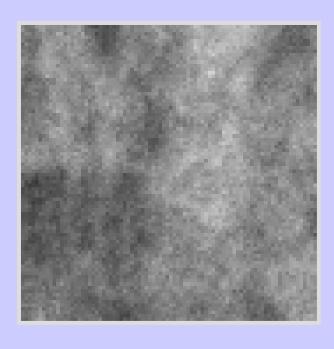
Example 2 Correlated Noise

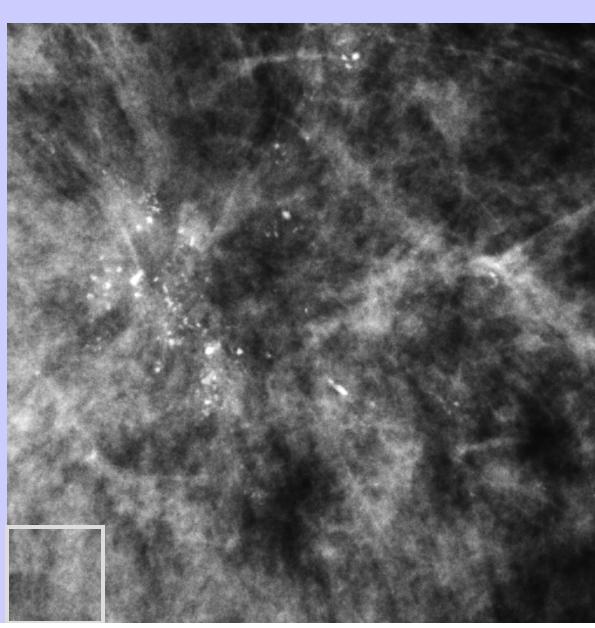




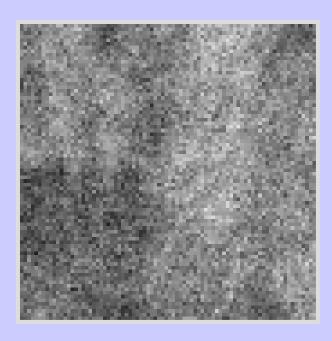


### Image without noise

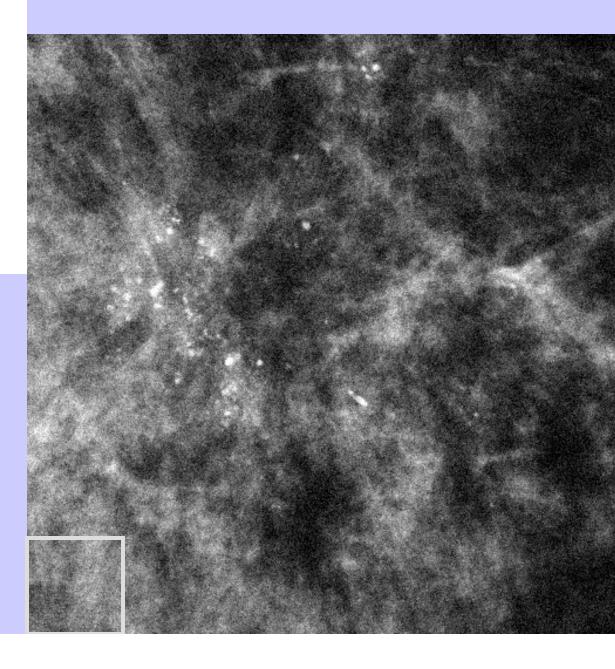




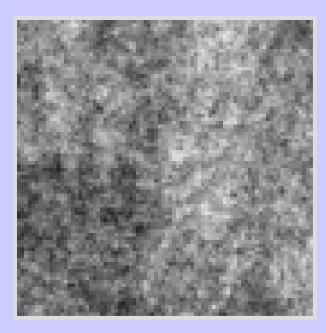
### 



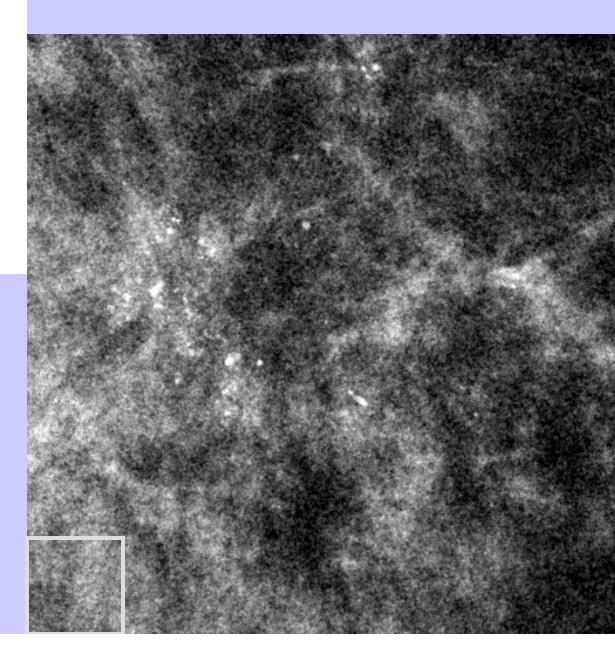
#### Uncorrelated noise



### 

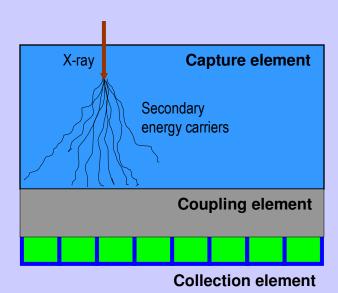


### Correlated noise



#### Noise factors

- 1. Capture element noise
- 2. Coupling element noise
- 3. Collection element noise



### Capture element noise

#### 1. Quantum noise

$$S = \varphi_0 \eta g \qquad N = \sigma_q^2 = \varphi_0 \eta (g^2 + \sigma_g^2)$$

$$SNR^2 = \varphi_0 \eta \frac{1}{1 + \sigma_g^2 / g^2}$$

#### Can be reduced by

- -Increasing patient dose (not detector dependent)
- -Increasing the thickness of the sensitive layer
  - => Resolution trade-off
- -Increasing the atomic number of the sensitive layer

### Capture element noise

#### 2. Conversion noise

$$S = \varphi_0 \eta g \qquad N = \sigma_q^2 = \varphi_0 \eta (g^2 + \sigma_g^2)$$

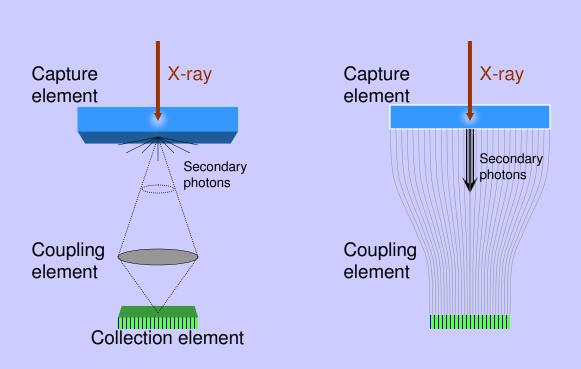
$$SNR^2 = \varphi_0 \eta \frac{1}{1 + \sigma_g^2 / g^2}$$

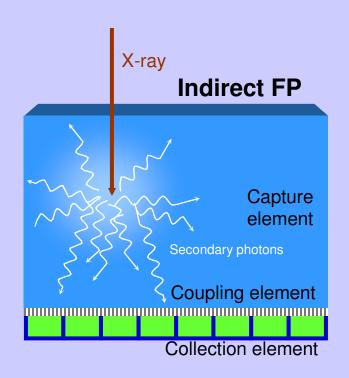
#### Can be reduced by

- -Higher-gain/lower-noise conversions
- -Generating and collecting more energy carriers
- -Having smaller number of conversion stages
- -Having larger fill factors in FP detectors

### Coupling element noise

- A conversion noise source
  - Dominant problem in lens-coupled DR systems
  - Can be improved by direct coupling or fiber-optic taper





#### Collection element noise

#### 1. Conversion noise

- ~ Efficiency by which secondary energy-carriers are captured
- Can be improved by light spectral matching and larger fill factors

#### 2. Additive electronic noise

- Due to background electronic noise
- Dominant problem for DR detectors at very low exposures, limiting fluoro applications
- Leads to a drop in DQE at very low exposures
- Can be improved by improved electronic or cooling the detector (in FP and CCD/CMOS systems)

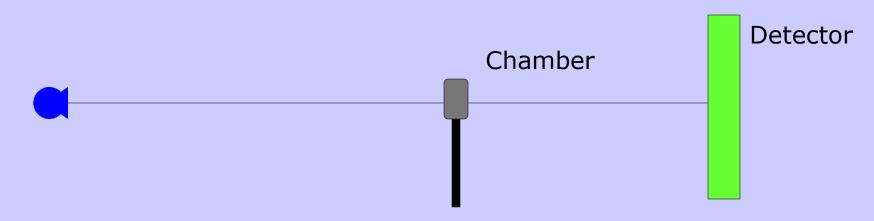
#### Collection element noise

#### 3. Structured noise

- Due to detector response non-uniformity
- Dominant problem for DR and CR detectors at high exposures
- Leads to drop in DQE at high exposures
- Can be improved by improving uniformity of the sensitive layer
- DR: Can by improved by reducing pixel-to-pixel variations and applying rigorous gain calibration

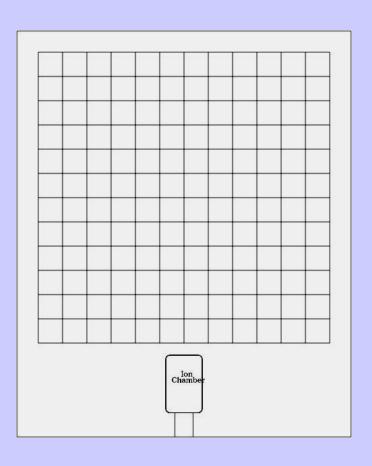
### NPS methodology

- · Uniform image acquisition
  - Largest possible SID
  - Desired technique
  - Uniform images at various exposures corresponding to the desired application of the system
  - Exposure precisely measured free-in-air



### NPS processing steps

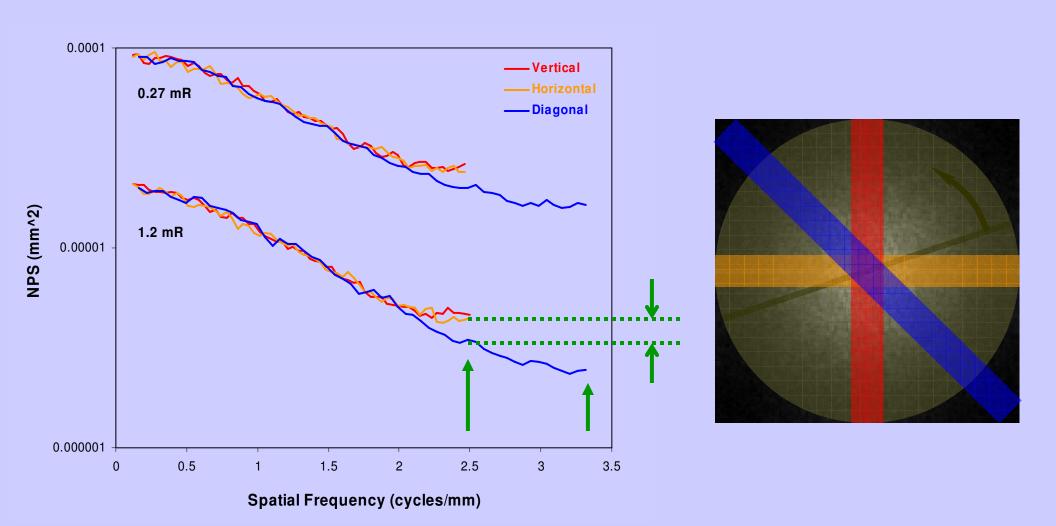
- Linearization wrt exposure
- Division of the image into small ROIs (sizes consistent with the desired precision of the resultant NPS)
- · Detrending
- Fourier analysis
- Averaging ROI NPS
- Extracting directional 1D-NPS



### NPS methodology

- · Uniform image processing
  - Subtract a 2<sup>nd</sup>-order polynomial 2D fit from each ROI
  - Convert noise to relative noise by dividing the data by their DC value
  - Apply a Hamming filter and Fourier transformation (FFT) to obtain each ROI's NPS
  - Normalize each spectrum to that of a reference ROI
  - Assess the exposure at the reference ROI
  - Average ROI NPS to obtain the overall NPS

### NPS, Orthogonal vs Diagonal



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# Noise and resolution => SNR

- Threshold contrast and diameter ~ 1/SNR (Rose model)
- Higher the SNR =>
   Features w/ smaller C and D can be detected

$$SNR_{actual}^2 = \frac{G \times MTF^2(f)}{NPS(f)}$$

### Efficiency

- Best characterized by the detective quantum efficiency (DQE):
  - Ability of a detector to utilize the maximum possible SNR provided by the finite number of x-ray photons forming the image

$$DQE(f) = \frac{SNR_{actual}^{2}}{SNR_{ideal}^{2}} = \frac{G \times MTF^{2}(f)}{SNR_{ideal}^{2} \times NPS(f)}$$

### DQE methodology

$$DQE(f) = \frac{G \cdot MTF^{2}(f)}{\left(SNR_{ideal}^{2} / X\right) \cdot X \cdot NPS(f)}$$

G => Gain factor = 1

MTF => Measured

NPS => Measured

X => Measured

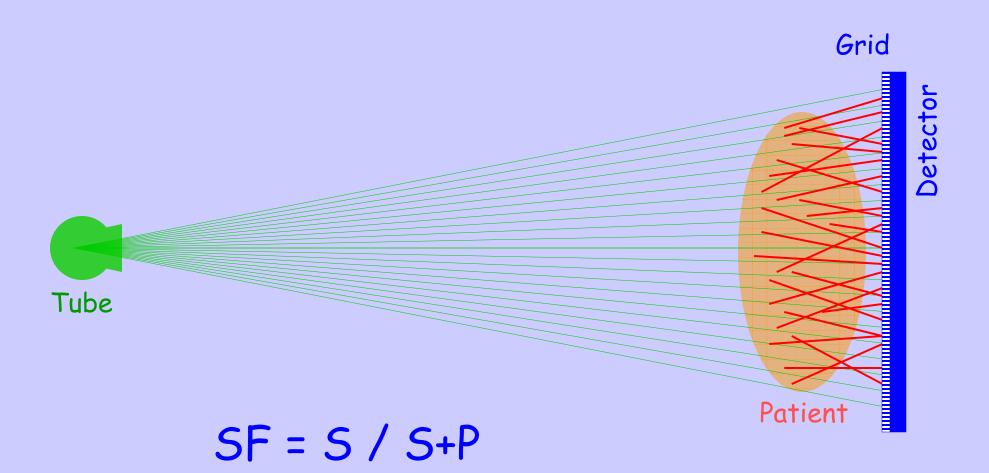
SNR<sup>2</sup><sub>ideal</sub>/X => Estimated

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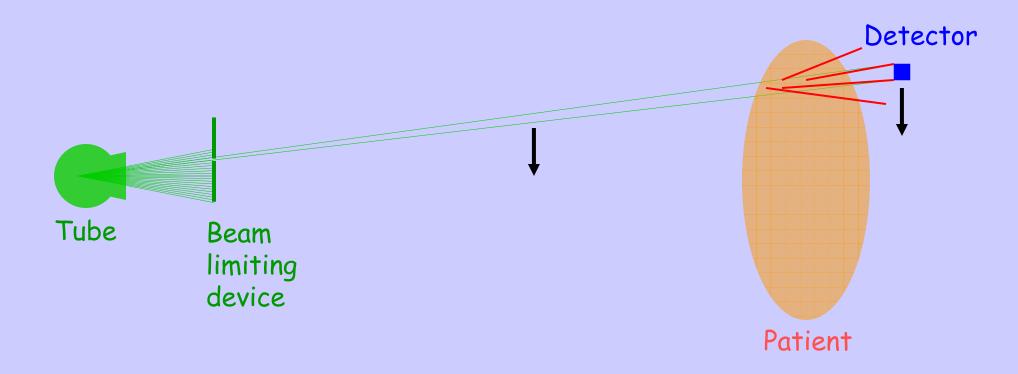
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### Scatter (full-field)



### Scatter (slot-scan)



#### Scatter effect

· Contrast

$$C_{ws} = C_{wo} (1-SF)$$

Differential signal

$$dS_{ws} = dS_{wo}$$

Relative noise

$$N_{ws}^2 = N_{wo}^2 (1-SF)$$

· Differential SNR

$$SNR_{ws}^2 = SNR_{wo}^2 (1-SF)$$

#### Scatter effect

• Differential SNR + grid attenuation  $SNR^2_{ws} = t * SNR^2_{wo} (1-SF)$ 

Effective DQE:

eDQE = t (1-SF) DQE

## DQE limitations, e.g.,

Wide-beam (WB) flat-panel detector

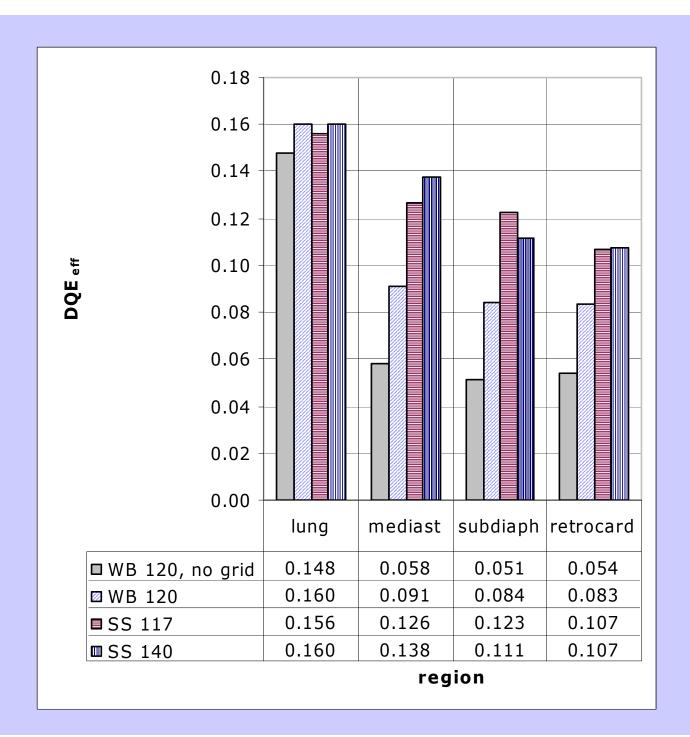
Slot-scan (SS)
CCD-based detector

$$DQE(0) = 45\%$$

$$DQE(0) = 18\%$$







# Basic descriptors of the digital image

- 1. Field of view
- 2. Uniformity
- 3. Spatial artifacts
- 4. Latitude
- 5. Spatial resolution

- 6. Noise
- 7. Efficiency
- 8. Scatter sensitivity
- 9. Speed
- 10.Lag

### Speed

#### Analog systems

 Defined in terms of exposure required to achieve good analog image quality (i.e., OD)

$$S = 1 / K_S$$

 $K_S$  = air kerma in uGy to achieve unit OD (ISO 9236-1, 2004)

#### Digital systems

- OD is irrelevant
- Image quality = SNR
- Speed should be defined in terms of exposure required to achieve good digital image quality (i.e., SNR)

# Digital speed (S<sub>d</sub>)

• eDQE => SNR2 per unit exposure

$$S_d = \frac{S_0}{eDQE_0(0)} eDQE(0)$$

 $S_0$  and eDQE<sub>0</sub> = speed and eDQE of an anatomy-specific "standard" film radiographic system

# Digital speed (S<sub>d</sub>)

Example, Chest radiography:

$$S_0 = 400$$

120 kVp

12:1 grid

 $=> S_d = 400 / 0.075 eDQE$ 

$$t = 0.5$$

$$SF_0 = 0.4$$

 $DQE_{0} = 0.2$ 

# Basic descriptors of the digital image

- 1. Field of view
- 2. Uniformity
- 3. Spatial artifacts
- 4. Latitude
- 5. Spatial resolution

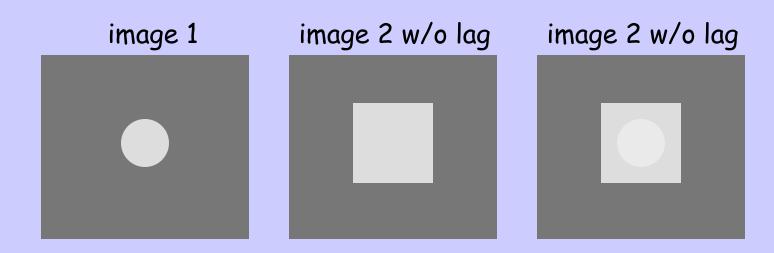
- 6. Noise
- 7. Efficiency
- 8. Scatter sensitivity
- 9. Speed
- 10.<u>Laq</u>

### Lag

- a) Residual signal
- b) Sensitivity fatigue

## a) Residual signal

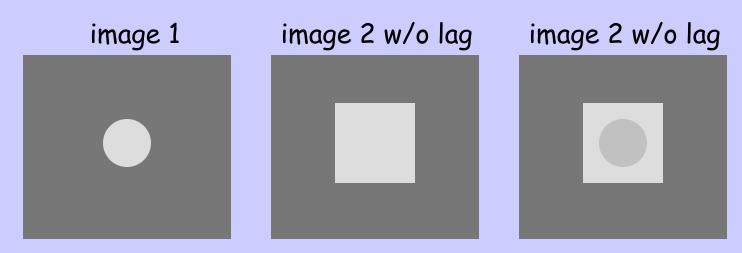
- Incomplete read-out of charge from the detector
- Residual <u>positive</u> contrast shadows



Can be corrected by subtracting a fraction of last image

# b) Sensitivity fatigue

- Due to reduced sensitivity after an exposure has been acquired
- Residual <u>negative</u> contrast shadows on subsequent images



Can be corrected by adding a fraction of last image

#### Summary

- 1. Decoupling of capture and display in digital imaging offers potential as well as challenges for improved image quality
- 2. Lag, uniformity, and artifacts are unique attributes/challenges of digital rad/fluoro systems
- 3. MTF, NPS, and DQE use slightly new definitions and metrology for digital systems

#### Summary

- 4. The primary image quality factor for digital radiographic systems is the SNR per unit exposure (i.e., DQE) taking into account scattered radiation
- 5. Neglecting scatter sensitivity can misrepresent the clinical performance of imaging systems
- 6. DQE and scatter sensitivity can be used as the basis for defining speed for digital imaging systems

